

JAN 23 2004

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
244226US2SERIAL NO.
10/692,745

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Kohich KANAYAFILING DATE
October 27, 2003

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/N.T./	AA	5,987,227	11/16/1999	T. ENDO, et al.			
	AB	4,815,725	03/28/1989	K. KANAYA			
	AC	4,976,421	12/11/1990	K. KANAYA			
	AD	5,131,079	07/14/1992	S. MIYAWAKI, et al.			
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	AF	5,165,675	11/24/1992	K. KANAYA			
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/N.T./	AO	5,784,663	07/21/1998	M. HAYASHI, et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/N.T./	AP	2001-216105	08/10/2001	JAPAN (with English Abstract)		X
/N.T./	AQ	2000-200226	07/18/2000	JAPAN (with English Abstract)		X
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
	AX		
	AY		
	AZ		

☐ Additional References sheet(s) attached

Examiner

/Nghi Tran/

Date Considered

06.19.07

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 244226US2		SERIAL NO. 10/692,745	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kohich KANAYA			
				FILING DATE October 27, 2003		GROUP 2142	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/N.T./	AA	2002/0133543 A1	09/19/2002	Y. FUJIWARA			
/N.T./	AB	2002/0063877 A1	05/30/2002	J. M. LUCIVERO, et al.			
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	AD						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/N.T./	AO	2001-75892	03/23/2001	JAPAN (with English Abstract)			X
/N.T./	AP	2001-24822	01/26/2001	JAPAN (with English Abstract)			X
	AQ						
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	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner /Nghi Tran/					Date Considered 06.18.07		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



LIST OF RELATED CASES

	<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent Appl. Publication No.</u>	<u>Inventor/ Applicant</u>
/N.T./	244226US2*	10/692,745	10/27/03	2004/0139164	KANAYA
/N.T./	259131US2	10/942,835	09/17/04		IZUMIKAWA et al.

*Present Application; listed for information
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/Ngh Tran/

06.28.07